


<b>Search Notes</b>  	<b>Application/Control No.</b>  10653757	<b>Applicant(s)/Patent Under Reexamination</b>  LUSTIG ET AL.
	<b>Examiner</b>  Washburn, Douglas N	<b>Art Unit</b>  2863

SEARCHED			
Class	Subclass	Date	Examiner
702	31	07/25/2006	DNW <i>DNW</i>
702	30	07/25/2006	DNW <i>↑</i>
436	46	07/25/2006	DNW <i>↑</i>
436	179	07/25/2006	DNW <i>↓</i>
702	30	02/26/2007	DNW <i>↓</i>
703	31	02/26/2007	DNW <i>DNW</i>

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search - Update - see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW <i>DNW</i>
EAST keyword/keyphrase - Update - see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	08/14/2006	DNW <i>↑</i>
B01J019/00 - Update - see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
G01N021/52 - Update - see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	07/25/2006	DNW
G01N033/00 - Update - see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	07/25/2006	DNW
702/30, 31 - Update - see printout - (USPGPUB; USPAT; USOCR)	07/25/2006	DNW
Hoff, M AU 2857; 101 consult; suggested 101 rejection applicable to method claims	06/13/2006	DNW
G01N021/52 see printout - (USPGPUB; USPAT; USOCR; FRPS; EPO; JPO; DERWENT; IBM_TDB)	07/25/2006	DNW
422/119, 122, 130	08/14/2006	DNW
IEEE keyword/keyphrase - see printout - (USPGPUB; USPAT; USOCR; FRPS; EPO; JPO; DERWENT; IBM-TDB)	08/01/2006	DNW
Ludlow, J AU 1743; consult regarding claims 22, 27 and 32; suggested search 436/174, 179	07/24/2006	DNW
Inventor name search - update - see printout - (USPGPUB; USPAT; USOCR; FRPS; EPO; JPO; DERWENT; IBM-TDB)	02/26/2007	DNW
EAST keyword/keyphrase - update - see printout - (USPGPUB; USPAT; USOCR; FRPS; EPO; JPO; DERWENT; IBM-TDB)	02/26/2007	DNW
G06F19/00 (USPGPUB; USPAT; USOCR; FRPS; EPO; JPO; DERWENT; IBM-TDB)	02/26/2007	DNW <i>↓</i>
702/30, 31 (USPGPUB; USPAT; USOCR)	02/26/2007	DNW <i>DNW</i>

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner